


<b>Search Notes</b>  	<b>Application/Control No.</b>  10574774	<b>Applicant(s)/Patent Under Reexamination</b>  KAIFU ET AL.
	<b>Examiner</b>  Liam J Heincer	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
528	129	2/27/08	LH
	219		
528	137, 155	12/29/2009	LH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	2/27/08	LH
Inventor Name search	2/27/08	LH
EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	10/3/2008	LH
EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	4/15/09	LH
EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	12/29/2009	LH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
528	129, 137, 155	12/29/2009	LH

--	--